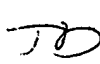
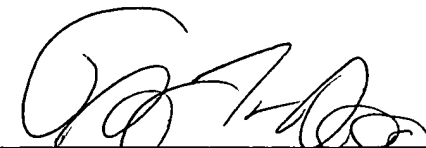


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	AD						
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	AF						
OTHER DOCUMENTS							
	AG	D. Brisbin, A. Strachan, and P. Chaparala, " <i>Breakdown Walk-in: A New PMOS Failure Mode in High Power BiCMOS Applications</i> ," presented at the IEEE 2003 International Integrated Reliability Workshop, at S. Lake Tahoe, California, on October 22, 2003, and published in the 2003 IEEE International Integrated Reliability Workshop Final Report (February 2004) (four pages)					
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